Please replace paragraph [0083] with the following amended paragraph:

[0083] The wafer holder into which the foregoing electrodes had been attached

was mounted as represented in Fig. 1 on a pedestal 15 made of SUS steel, via

cylindrical support pieces 7 also made of SUS steel. This assembly was installed in

the processing-chamber 10 interior of a semiconductor manufacturing device, and

with bellows 16 made of nickel a hermetic seal was formed between the pedestal

and the chamber. In this case, in 3 equidistantly spaced places in the wafer holder

holes for penetration by the lift pins 5 were provided, wherein the wafer holder was

set into place so that the lift pins 5 having been fixed to the chamber 10 would

penetrate through the holes. The heights of the tip-end faces of the three lift pins

were adjusted so that the height variance would be within 0.5 mm.

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